élantec
HIGH PERFORMANCE ANALOG INTEGRATED CIRCUITS

EHA2500 Series

High Slew Rate Operational Amplifier

Features

- High slew rate—100V/μs
- Fast settling—200ns
- Wide power bandwidth
- High input impedance
- Low offset current—25nA
- Compensated versions available

Applications

- Data acquisition systems
- R.F. amplifiers
- Video amplifiers
- Signal generators
- Pulse amplification
- High speed sample and holds

General Description

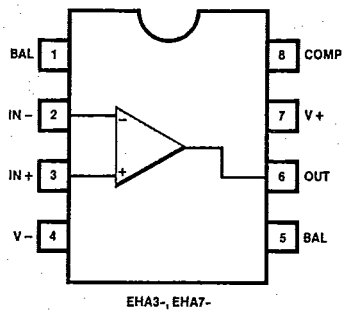
Elantec's EHA2500 Series of monolithic high slew rate amplifiers is designed and optimized for high slew rates and wide bandwidths. Three different types are offered. The EHA250X series is unity gain stable and low cost. The EHA251X series has twice the bandwidth and slew rate of the EHA250X series and is also unity gain stable. For the best AC performance choose the EHA252X series which has the highest slew rate –120V/μs—and the widest bandwidths available. The EHA252X series is stable with closed loop gains as low as three.

These devices are fabricated using Elantec's DInamic Dielectrically Isolated process that has excellent PNPs and NPNs that allow higher bandwidths than standard junction isolated process.

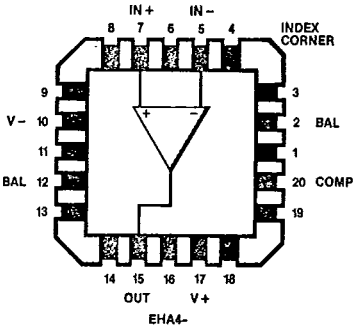
Elantec's high speed amplifiers are widely used in military, video and medical applications. They are especially suited for high speed video amplifiers, pulse detectors, and wide bandwidth filters.

Elantec's facilities comply with MIL-I-45208A and other applicable quality specifications. For information on Elantec's military processing, request our brochure: *Elantec's Military Processing—Monolithic Products.*

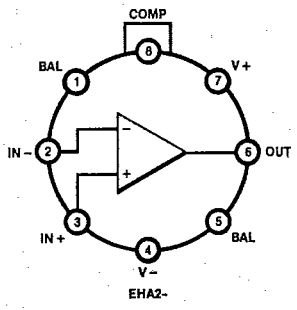
Connection Diagrams



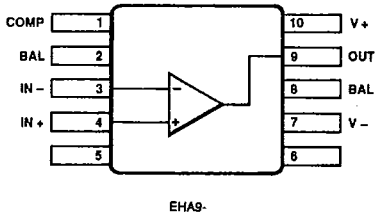
EHA3-, EHA7-



EHA4-



EHA2-



EHA9-

TOP VIEWS

EHA2500 Series

High Slew Rate Operational Amplifier

Selection Guide

Part Number	Temp.	V_{OS} (Max) mV	I_{BIAS} (Max) nA	I_{OS} (Max) nA	G_{BW} (Typ) MHz	PBW (Min) kHz	S_R (Min) V/μs	t_{SET} (Typ) μs	PSRR, CMRR (Min) dB	R_{IN} (Min) MΩ	Minimum Stable Gain
EHA2500	M	5	200	25	12	350	25	0.33	80	25	1
EHA2502	M	8	250	50	12	300	20	0.33	74	20	1
EHA2505	C	8	250	50	12	300	20	0.33	74	20	1
EHA2510	M	8	200	25	12	750	50	0.25	80	50	1
EHA2512	M	10	250	50	12	600	40	0.25	74	40	1
EHA2515	C	10	250	50	12	600	40	0.25	74	40	1
EHA2520	M	8	200	25	20	1500	100	0.20	80	50	3
EHA2522	M	10	250	50	20	1200	80	0.20	74	40	3
EHA2525	C	10	250	50	20	1200	80	0.20	74	40	3

Ordering Information

Dice (Note 1) (EHA0–)	14-Pin DIP Ceramic (EHA1–)	TO–99 Metal Can (EHA2–)	8-Pin DIP Plastic (EHA3–)	LCC 20-Pin (EHA4–)	8-Pin DIP Cerdip (EHA7–)	10-Pin Flat-Pack (EHA9–)
EHA0–2500–6		EHA2–2500/883B EHA2–2500–2		EHA4–2500/883B	EHA7–2500/883B EHA7–2500–2	EHA9–2500/883B
EHA0–2502–6		EHA2–2502/883B EHA2–2502–2		EHA4–2502/883B	EHA7–2502/883B EHA7–2502–2	EHA9–2502/883B
EHA0–2505–6		EHA2–2505–5	EHA3–2505–5		EHA7–2505–5	
EHA0–2510–6		EHA2–2510/883B EHA2–2510–2		EHA4-2510/883B	EHA7–2510/883B EHA7–2510–2	EHA9–2510/883B
EHA0–2512–6		EHA2–2512/883B EHA2–2512–2		EHA4–2512/883B	EHA7–2512/883B EHA7–2512–2	EHA9–2512/883B
EHA0–2515–6		EHA2–2515–5	EHA3–2515–5		EHA7–2515–5	
EHA0–2520–6	Consult Factory	EHA2–2520/883B EHA2-2520–2		EHA4–2520/883B	EHA7–2520/883B EHA7–2520–2	EHA9–2520/883B
EHA0–2522–6		EHA2–2522/883B EHA2–2522–2		EHA4–2522/883B	EHA7–2522/883B EHA7–2522–2	EHA9–2522/883B
EHA0–2525–6		EHA2–2525–5	EHA3–2525–5		EHA7–2525–5	

Note 1: Dice are available in waffle packs. Consult factory for more information.
Note 2: Consult factory for special packaging or temperature range requirements.

PREFIX		SUFFIX	
P		–1	0°C to 200°C
EHA2–	TO–99 Metal Can MDP0004	–2	–55°C to 125°C
EHA3–	8-Pin Plastic DIP MDP0006	–3	
EHA4–	Leadless Chip Carrier (LCC) . . MDP0007	–4	–25°C to 85°C
EHA7–	8-Pin CERDIP MDP0010	–5	0°C to 75°C
EHA9–	Flat-Pack MDP0020	–6	100% 25°C Probe (Dice Only)
EHA0–	Dice	–7	
		/883B	See Elantec's "Military Processing—Monolithic Products".
		–9	

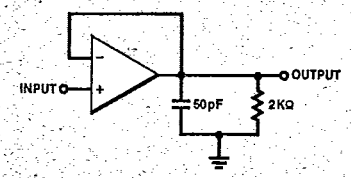
EHA2500 Series

High Slew Rate Operational Amplifier

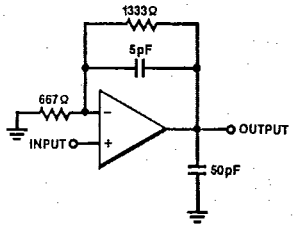
Test Level Descriptions

Test Level	Test Procedure
I	100% production tested and QA sample tested per QA test plan QCX0002.
II	100% production tested at $T_A = 25°C$, and QA sample tested at $T_A = 25°C$, T_{MAX} and T_{MIN} per QA test plan QCX0002.
III	QA sample tested per QA test plan QCX0002.
IV	Parameter is guaranteed (but not tested) by Design and Characterization Data.
V	Parameter is typical value for information purposes only.

AC Test Circuits

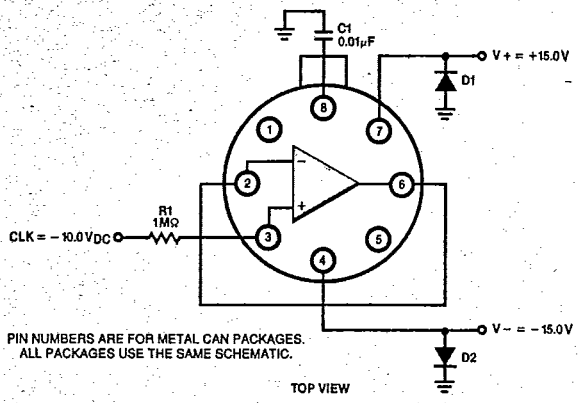


EHA250X AND EHA251X



EHA252X

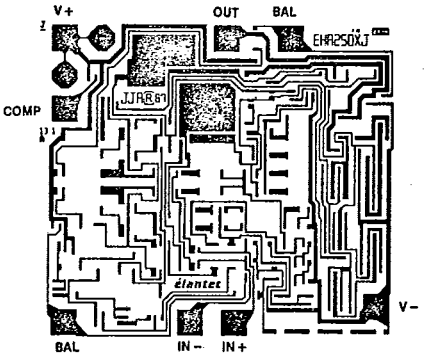
Burn-In Circuit



PIN NUMBERS ARE FOR METAL CAN PACKAGES.
ALL PACKAGES USE THE SAME SCHEMATIC.

TOP VIEW

Die Layout



DIE SIZE: 66 x 61 MILS

EHA2500/2502/2505

High Slew Rate Operational Amplifier

Absolute Maximum Ratings

V_S	Supply Voltage	±20V	T_A	Operating Temperature Range:	
V_{IN}	Differential Input Voltage	±15.0V		EHA2500/02	−55°C to +125°C
P_D	Maximum Power Dissipation	See Curves		EHA2505	0°C to +75°C
I_{OUT}	Peak Output Current	50mA	T_{ST}	Storage Temperature	−65°C to +150°C
				Lead Temperature (soldering, 5 seconds)	300°C

Important Note: All parameters having Min./Max. specifications are guaranteed. The Test Level column indicates the specific device testing actually performed during production and Quality Assurance inspection. Elantec performs most electrical tests using modern high-speed automatic test equipment, specifically the LTX 77 Series system. Unless otherwise noted, all tests are pulsed tests, therefore $T_J = T_C = T_A$.

DC Electrical Characteristics

$V_S = \pm 15V$, $R_S = 50\Omega$, $R_L = 100k\Omega$, $V_{CM} = 0V$, $V_{OUT} = 0V$, $T_{MIN} \leq T_A \leq T_{MAX}$, unless otherwise specified.

			EHA2500				EHA2502				EHA2505				
	Parameter	Test Conditions	Min.	Typ.	Max.	Test Level	Min.	Typ.	Max.	Test Level	Min.	Typ.	Max.	Test Level	Units
V_{OS}	Offset Voltage	T_A=25°C		2	5	I		4	8	I		4	8	I	mV
					8	I			10	I			10	III	mV
$\Delta V_{OS}/\Delta T$	Offset Voltage Drift			20		V		20		V		20		V	µV/°C
I_B	Bias Current (Note 1)	T_A=25°C		100	200	I		125	250	I		125	250	I	nA
					400	I			500	I			500	III	nA
I_{OS}	Offset Current	T_A=25°C		10	25	I		20	50	I		20	50	I	nA
					50	I			100	I			100	III	nA
R_{IN}	Input Resistance	T_A=25°C	25	50		IV	20	50		IV	20	50		IV	MΩ
V_{CMR}	Common-Mode Range		±10.0			I	±10.0			I	±10.0			II	V
CMRR	Common-Mode Rejection Ratio (Note 2)	ΔV_{CM} = ±10V	80	90		I	74	90		I	74	90		II	dB
PSRR	Power Supply Rejection Ratio (Note 3)	ΔV_S = ±5V	80	90		I	74	90		I	74	90		II	dB
A_{VOL}	Large Signal Voltage Gain	R_L=2kΩ, V_{OUT} = ±10V, T_A=25°C	20	30		I	15	25		I	15	25		I	V/mV
	(Note 4)	R_L=2kΩ, V_{OUT} = ±10V	15			I	10			I	10			III	V/mV
V_{OUT}	Output Voltage Swing	R_L=2kΩ	±10.0	±12.0		I	±10.0	±12.0		I	±10.0	±12.0		II	V
I_{OUT}	Output Current	V_{OUT} = ±10V, T_A=25°C	±10	±20		I	±10	±20		I	±10	±20		I	mA
		V_{OUT} = ±10V	±7.5			I	±7.5			I	±7.5			III	mA
I_{CC}	Supply Current (Note 5)	T_A=25°C		4	6	I		4	6	I		4	6	I	mA
					6.5	I			7	I			7	III	mA

EHA2500/2502/2505

High Slew Rate Operational Amplifier

AC Electrical Characteristics

$V_S = \pm 15V$, $A_V = 1$, $R_S = 50\Omega$, $R_L = 2k\Omega$, $C_L = 50pF$, $V_{OUT} = \pm 200mV$, $T_{MIN} \leq T_A \leq T_{MAX}$, unless otherwise specified (See AC test circuit)

	Parameter	Test Conditions	EHA2500				EHA2502				EHA2505				Units
			Min.	Typ.	Max.	Test Level	Min.	Typ.	Max.	Test Level	Min.	Typ.	Max.	Test Level	
t_r, t_f	Rise and Fall Times	$T_A = 25°$		25	50	I		25	50	I		25	50	I	ns
					60	I			60	I			60	III	ns
SR	Slew Rate	$V_{OUT} = \pm 5V$, $T_A = 25°C$	±25	±30		I	±20	±30		I	±20	±30		I	V/μs
		$V_{OUT} = \pm 5V$	±20			I	±15			I	±15			III	V/μs
GBW	Gain Bandwidth Products	$A_V \geq 10$, $T_A = 25°C$		12		V		12		V		12		V	MHz
FPBW	Full Power Bandwidth (Note 6)	$V_{OUT} = \pm 10V$, $T_A = 25°C$	350	500		IV	300	500		IV	300	500		IV	kHz
O.S.	Overshoot	$T_A = 25°C$		25	40	I		25	50	I		25	50	I	%
					50	I			60	I			60	III	%
t_s	Settling Time to 0.1%	$V_{OUT} = \pm 5V$, $T_A = 25°C$		0.33		V		0.33		V		0.33		V	μs

Note 1: Both input currents, I_{B+} and I_{B-}, are tested individually.

Note 2: For CMRR+, $V_{CM} = 0$ to +10V and for CMRR−, $V_{CM} = 0$ to −10V.

Note 3: For PSRR+, $V_{S+} = +10V$ to +20V with $V_{S-} = -15V$.
For PSRR−, $V_{S-} = -10V$ to −20V with $V_{S+} = +15V$.

Note 4: For A_{VOL+}, $V_{OUT} = 0$ to +10V and for A_{VOL-}, $V_{OUT} = 0$ to −10V.

Note 5: Both positive and negative supply currents, I_{CC+} and I_{CC-}, are tested.

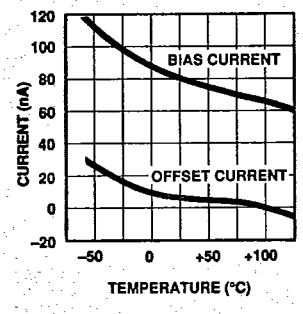
Note 6: The Full Power Bandwidth is guaranteed by testing slew rate. $FPBW = SR / (2\pi V_P)$.

EHA2500/2502/2505

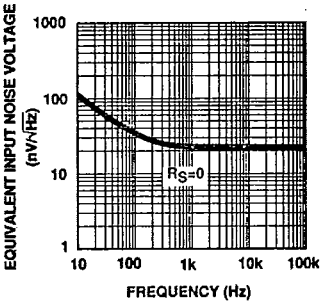
High Slew Rate Operational Amplifier

Typical Performance Curves

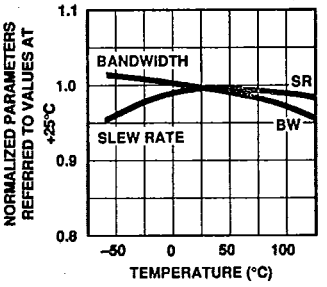
Input Bias and Offset Current vs Temperature



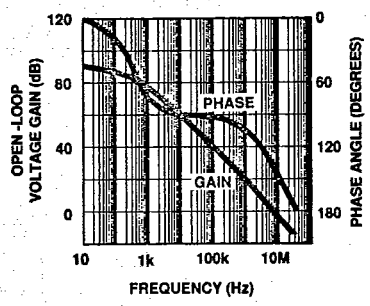
Equivalent Input Noise Voltage vs Frequency



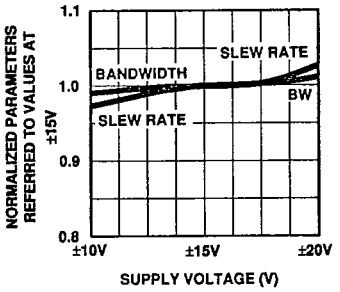
Normalized AC Parameters vs Temperature



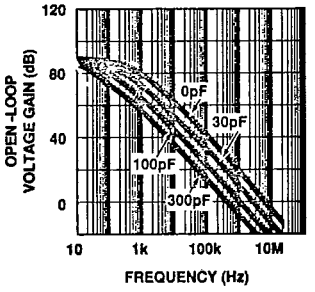
Open-Loop Frequency and Phase Response



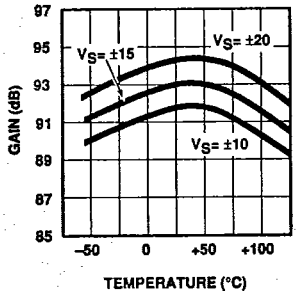
Normalized AC Parameters vs Supply Voltage at 25°C



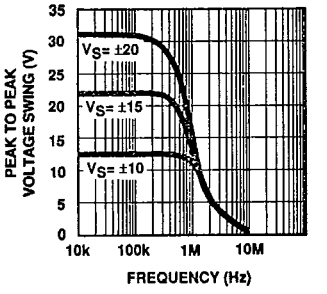
Open-Loop Frequency Response For Various Compensation



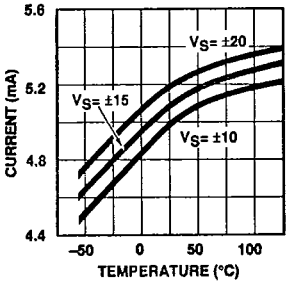
Open-Loop Voltage Gain vs Temperature



Output Voltage Swing vs Frequency at +25°C



Power Supply Current vs Temperature

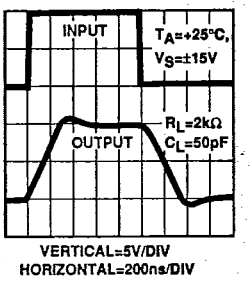


EHA2500/2502/2505

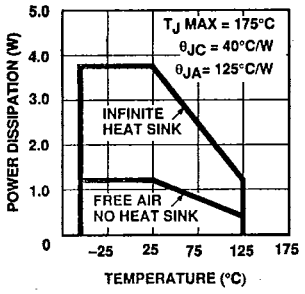
High Slew Rate Operational Amplifier

Typical Performance Curves - (continued)

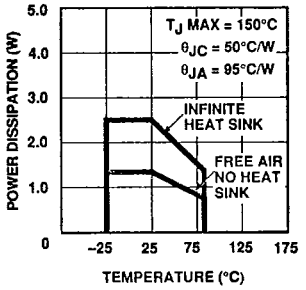
Voltage Follower Pulse Response



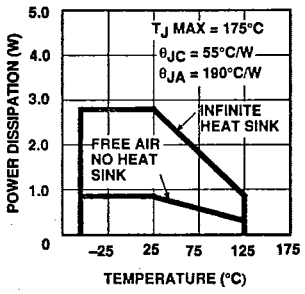
8-Lead CerDIP Maximum Power Dissipation vs Ambient Temperature



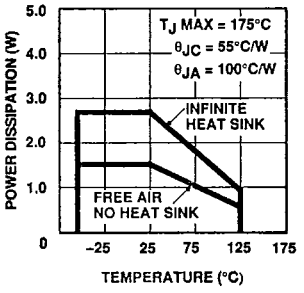
8-Lead Plastic DIP Maximum Power Dissipation vs Ambient Temperature



8-Lead TO-99 Metal Can Maximum Power Dissipation vs Ambient Temperature



20-Pad LCC Maximum Power Dissipation vs Ambient Temperature



EHA2510/2512/2515

High Slew Rate Operational Amplifier

Absolute Maximum Ratings

V_S	Supply Voltage	±20V	T_A	Operating Temperature Range:	
V_{IN}	Differential Input Voltage	±15.0V		EHA2510/12	−55°C to +125°C
P_D	Maximum Power Dissipation	See Curves		EHA2515	0°C to +75°C
I_{OUT}	Peak Output Current	50mA	T_{ST}	Storage Temperature	−65°C to +150°C
				Lead Temperature (soldering, 5 seconds)	300°C

Important Note: All parameters having Min./Max. specifications are guaranteed. The Test Level column indicates the specific device testing actually performed during production and Quality Assurance inspection. Elantec performs most electrical tests using modern high-speed automatic test equipment, specifically the ITX 77 Series system. Unless otherwise noted, all tests are pulsed tests, therefore $T_J = T_C = T_A$.

DC Electrical Characteristics

$V_S = \pm 15V$, $R_S = 50\Omega$, $R_L = 100k\Omega$, $V_{CM} = 0V$, $V_{OUT} = 0V$, $T_{MIN} \leq T_A \leq T_{MAX}$, unless otherwise specified.

	Parameter	Test Conditions	EHA2510				EHA2512				EHA2515				Units
			Min.	Typ.	Max.	Test Level	Min.	Typ.	Max.	Test Level	Min.	Typ.	Max.	Test Level	
V_{OS}	Offset Voltage	$T_A = 25°C$		4	8	I		5	10	I		5	10	I	mV
					10	I			14	I			14	III	mV
$\Delta V_{OS}/\Delta T$	Offset Voltage Drift			20		V		25		V		30		V	µV/°C
I_B	Bias Current (Note 1)	$T_A = 25°C$		100	200	I		125	250	I		125	250	I	nA
					400	I			500	I			500	III	nA
I_{OS}	Offset Current	$T_A = 25°C$		10	25	I		20	50	I		20	50	I	nA
					50	I			100	I			100	III	nA
R_{IN}	Input Resistance	$T_A = 25°C$	50	100		IV	40	100		IV	40	100		IV	MΩ
V_{CMR}	Common-Mode Range		±10.0			I	±10.0			I	±10.0			II	V
CMRR	Common-Mode Rejection Ratio (Note 2)	$\Delta V_{CM} = \pm 10V$	80	90		I	74	90		I	74	90		II	dB
PSRR	Power Supply Rejection Ratio (Note 3)	$\Delta V_S = \pm 5V$	80	90		I	74	90		I	74	90		II	dB
A_{VOL}	Large Signal Voltage Gain	$R_L = 2k\Omega$, $V_{OUT} = \pm 10V$, $T_A = 25°C$	10	15		I	7.5	15		I	7.5	15		I	V/mV
	(Note 4)	$R_L = 2k\Omega$, $V_{OUT} = \pm 10V$	7.5			I	5			I	5			III	V/mV
V_{OUT}	Output Voltage Swing	$R_L = 2k\Omega$	±10.0	±12.0		I	±10.0	±12.0		I	±10.0	±12.0		II	V
I_{OUT}	Output Current	$V_{OUT} = \pm 10V$, $T_A = 25°C$	±10	±20		I	±10	±20		I	±10	±20		I	mA
		$V_{OUT} = \pm 10V$	±7.5			I	±7.5			I	±7.5			III	mA
I_{CC}	Supply Current (Note 5)	$T_A = 25°C$		4	6	I		4	6	I		4	6	I	mA
					6.5	I			7	I			7	III	mA

EHA2510/2512/2515

High Slew Rate Operational Amplifier

AC Electrical Characteristics

$V_S = \pm 15V$, $A_V = 1$, $R_S = 50\Omega$, $R_L = 2k\Omega$, $C_L = 50pF$, $V_{OUT} = \pm 200mV$, $T_{MIN} \leq T_A \leq T_{MAX}$, unless otherwise specified (See AC test circuit)

	Parameter	Test Conditions	EHA2510				EHA2512				EHA2515				Units
			Min.	Typ.	Max.	Test Level	Min.	Typ.	Max.	Test Level	Min.	Typ.	Max.	Test Level	
t_r, t_f	Rise and Fall Times	$T_A = 25°C$		25	50	I		25	50	I		25	50	I	ns
					60	I			60	I			60	III	ns
SR	Slew Rate	$V_{OUT} = \pm 5V$, $T_A = 25°C$	±50	±65		I	±40	±60		I	±40	±60		I	V/μs
		$V_{OUT} = \pm 5V$	±45			I	±35			I	±35			III	V/μs
GBW	Gain Bandwidth Products	$A_V \geq 10mV$, $T_A = 25°C$		12		V		12		V		12		V	MHz
FPBW	Full Power Bandwidth (Note 6)	$V_{OUT} = \pm 10V$, $T_A = 25°C$	750	1000		IV	600	1000		IV	600	1000		IV	kHz
O.S.	Overshoot	$T_A = 25°C$		25	40	I		25	50	I		25	50	I	%
					50	I			60	I			60	III	%
t_s	Settling Time to 0.1%	$V_{OUT} = \pm 5V$		0.25		V		0.25		V		0.25		V	μs

Note 1: Both input currents, I_{B+} and I_{B-}, are tested individually.

Note 2: For CMRR+, $V_{CM} = 0$ to $+10V$ and for CMRR−, $V_{CM} = 0$ to $-10V$.

Note 3: For PSRR+, $V_{S+} = +10V$ to $+20V$ with $V_{S-} = -15V$.
For PSRR−, $V_{S-} = -10V$ to $-20V$ with $V_{S+} = +15V$.

Note 4: For A_{VOL+}, $V_{OUT} = 0$ to $+10V$ and for A_{VOL-}, $V_{OUT} = 0$ to $-10V$.

Note 5: Both positive and negative supply currents, I_{CC+} and I_{CC-}, are tested.

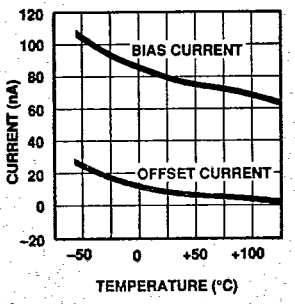
Note 6: The Full Power Bandwidth is guaranteed by testing slew rate, $FPBW = SR/(2\pi V_P)$.

EHA2510/2512/2515

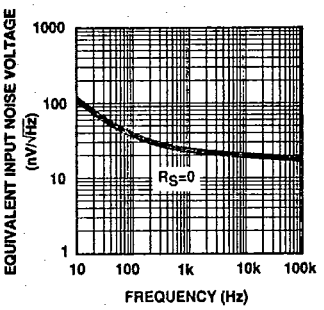
High Slew Rate Operational Amplifier

Typical Performance Curves

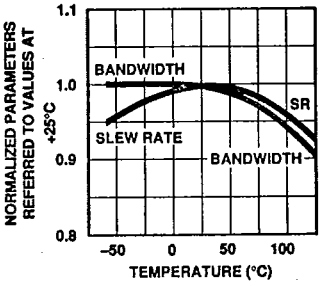
Input Bias and Offset Current vs Temperature



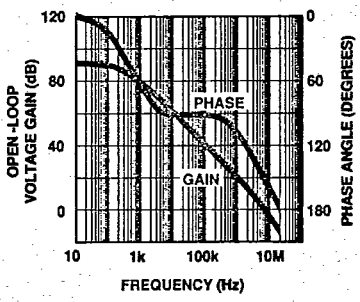
Equivalent Input Noise Voltage vs Frequency



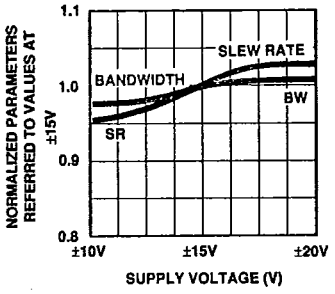
Normalized AC Parameters vs Temperature



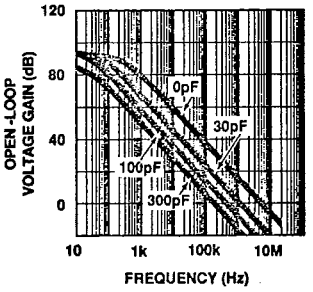
Open-Loop Frequency and Phase Response



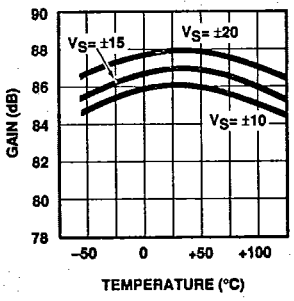
Normalized AC Parameters vs Supply Voltage at 25°C



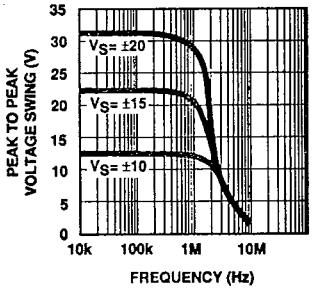
Open-Loop Frequency Response For Various Compensation



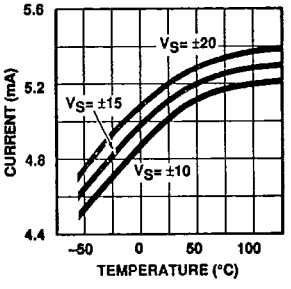
Open-Loop Voltage Gain vs Temperature



Output Voltage Swing vs Frequency at +25°C



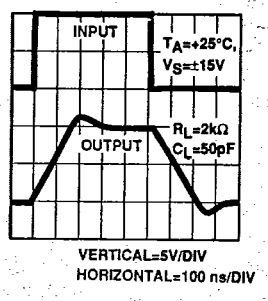
Power Supply Current vs Temperature



EHA2510/2512/2515
High Slew Rate Operational Amplifier

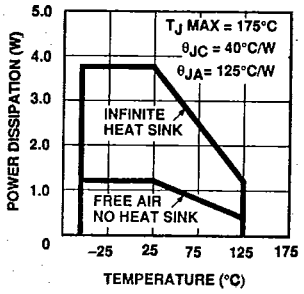
Typical Performance Curves

Voltage Follower Pulse Response

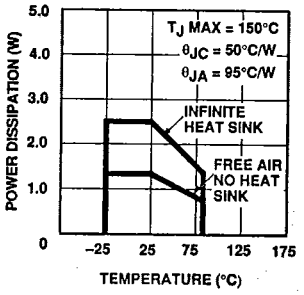


VERTICAL=5V/DIV
HORIZONTAL=100 ns/DIV

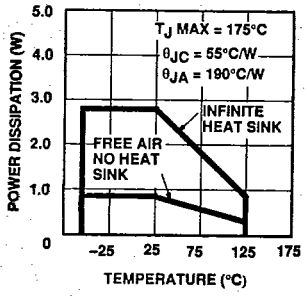
8-Lead CerDIP Maximum Power Dissipation vs Ambient Temperature



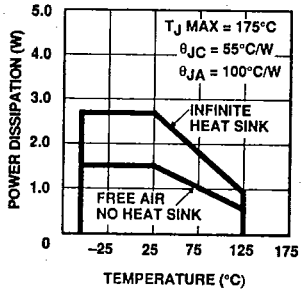
8-Lead Plastic DIP Maximum Power Dissipation vs Ambient Temperature



8-Lead TO-99 Metal Can Maximum Power Dissipation vs Ambient Temperature



20-Pad LCC Maximum Power Dissipation vs Ambient Temperature



EHA2520/2522/2525

High Slew Rate Operational Amplifier

Absolute Maximum Ratings

V_S	Supply Voltage	±20V	T_A	Operating Temperature Range:	
V_{IN}	Differential Input Voltage	±15.0V		EHA2520/22	−55°C to +125°C
P_D	Maximum Power Dissipation	See Curves		EHA2525	0°C to +75°C
I_{OUT}	Peak Output Current	50mA	T_{ST}	Storage Temperature	−65°C to +150°C
				Lead Temperature (soldering, 5 seconds)	300°C

Important Note: All parameters having Min./Max. specifications are guaranteed. The Test Level column indicates the specific device testing actually performed during production and Quality Assurance inspection. Elantec performs most electrical tests using modern high-speed automatic test equipment, specifically the LTX 77 Series system. Unless otherwise noted, all tests are pulsed tests, therefore $T_J = T_C = T_A$.

DC Electrical Characteristics

$V_S = \pm 15V$, $R_S = 50\Omega$, $R_L = 100k\Omega$, $V_{CM} = 0V$, $V_{OUT} = 0V$, $T_{MIN} \leq T_A \leq T_{MAX}$, unless otherwise specified.

			EHA2520				EHA2522				EHA2525				
	Parameter	Test Conditions	Min.	Typ.	Max.	Test Level	Min.	Typ.	Max.	Test Level	Min.	Typ.	Max.	Test Level	Units
V_{OS}	Offset Voltage	$T_A = 25°C$		4	8	I		5	10	I		5	10	I	mV
					10	I			14	I			14	III	mV
$\Delta V_{OS}/\Delta T$	Offset Voltage Drift			20		V		25		V		30		V	µV/°C
I_B	Bias Current (Note 1)	$T_A = 25°C$		100	200	I		125	250	I		125	250	I	nA
					400	I			500	I			500	III	nA
I_{OS}	Offset Current	$T_A = 25°C$		10	25	I		20	50	I		20	50	I	nA
					50	I			100	I			100	III	nA
R_{IN}	Input Resistance	$T_A = 25°C$	50	100		IV	40	100		IV	40	100		IV	MΩ
V_{CMR}	Common-Mode Range		±10.0			I	±10.0			I	±10.0			II	V
CMRR	Common-Mode Rejection Ratio (Note 2)	$\Delta V_{CM} = \pm 10V$	80	90		I	74	90		I	74	90		II	dB
PSRR	Power Supply Rejection Ratio (Note 3)	$\Delta V_S = \pm 5V$	80	90		I	74	90		I	74	90		II	dB
A_{VOL}	Large Signal Voltage Gain	$R_L = 2k\Omega$, $V_{OUT} = \pm 10V$, $T_A = 25°C$	10	15		I	7.5	7.5		I	7.5	15		I	V/mV
	(Note 4)	$R_L = 2k\Omega$, $V_{OUT} = \pm 10V$	7.5			I	5			I	5			III	V/mV
V_{OUT}	Output Voltage Swing	$R_L = 2k\Omega$	±10.0	±12.0		I	±10.0	±12.0		I	±10.0	±12.0		II	V
I_{OUT}	Output Current	$V_{OUT} = \pm 10V$, $T_A = 25°C$	±10	±20		I	±10	±20		I	±10	±20		I	mA
		$V_{OUT} = \pm 10V$	±7.5			I	±7.5			I	±7.5			III	mA
I_{CC}	Supply Current (Note 5)	$T_A = 25°C$		4	6	I		4	6	I		4	6	I	mA
					6.5	I			7	I			7	III	mA

EHA2520/2522/2525

High Slew Rate Operational Amplifier

AC Electrical Characteristics

$V_S = \pm 15V$, $A_V = 3$, $R_S = 50\Omega$, $R_L = 2k\Omega$, $C_L = 50pF$, $V_{OUT} = \pm 200mV$, $T_{MIN} \leq T_A \leq T_{MAX}$ unless otherwise specified (See AC test circuit)

	Parameter	Test Conditions	EHA2520				EHA2522				EHA2525				Units
			Min.	Typ.	Max.	Test Level	Min.	Typ.	Max.	Test Level	Min.	Typ.	Max.	Test Level	
t_r, t_f	Rise and Fall Times	$T_A = 25°C$		25	50	I		25	50	I		25	50	I	ns
					55	I			60	I			60	III	ns
SR	Slew Rate	$V_{OUT} = \pm 5V$, $T_A = 25°C$	±100	±120		I	±80	±120		I	±80	±120		I	V/μs
		$V_{OUT} = \pm 5V$	±84			I	±60			I	±60			III	V/μs
GBW	Gain Bandwidth Products	$A_V \geq 10mV$, $T_A = 25°C$	10	20		IV	10	20		IV	10	20		IV	MHz
FPBW	Full Power Bandwidth (Note 6)	$V_{OUT} = \pm 10V$, $T_A = 25°C$	1500	2000		IV	1200	1600		IV	1200	1600		IV	kHz
O.S.	Overshoot	$T_A = 25°C$		25	40	I		25	50	I		25	50	I	%
					45	I			60	I			60	III	%
t_s	Settling Time to 0.1%	$V_{OUT} = \pm 5V$, $T_A = 25°C$		0.20		V		0.20		V		0.20		V	μs

Note 1: Both input currents, I_{B-} and I_{B+}, are tested individually.

Note 2: For CMRR+, $V_{CM} = 0$ to +10V and for CMRR−, $V_{CM} = 0$ to −10V.

Note 3: For PSRR+, $V_{S-} = +10V$ to +20V with $V_{S+} = -15V$.
For PSRR−, $V_{S+} = -10V$ to −20V with $V_{S-} = +15V$.

Note 4: For A_{VOL+}, $V_{OUT} = 0$ to +10V and for A_{VOL-}, $V_{OUT} = 0$ to −10V.

Note 5: Both positive and negative supply currents, I_{CC+} and I_{CC-}, are tested.

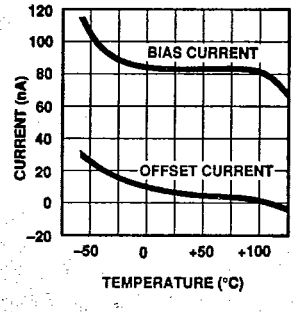
Note 6: The Full Power Bandwidth is guaranteed by testing slew rate. $FPBW = SR / (2\pi V_P)$.

EHA2520/2522/2525

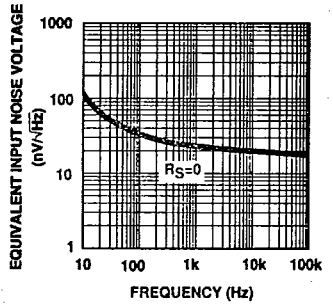
High Slew Rate Operational Amplifier

Typical Performance Curves

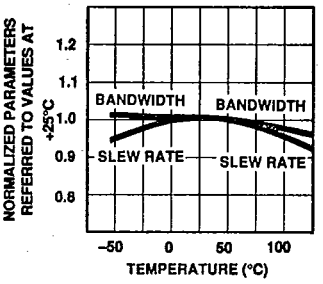
Input Bias and Offset Current vs Temperature



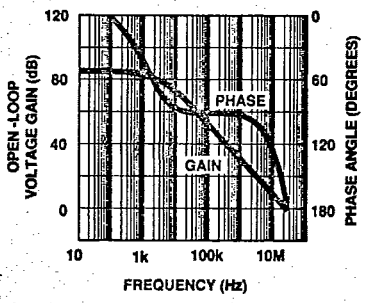
Equivalent Input Noise Voltage vs Frequency



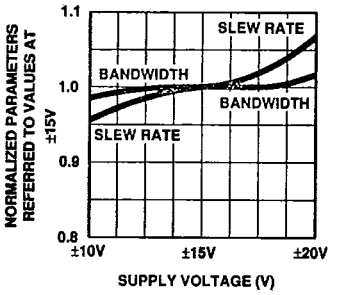
Normalized AC Parameters vs Temperature



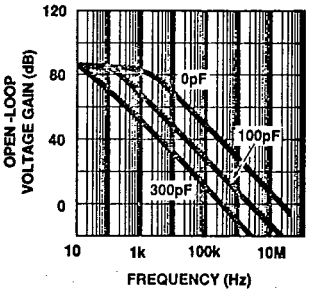
Open-Loop Frequency and Phase Response



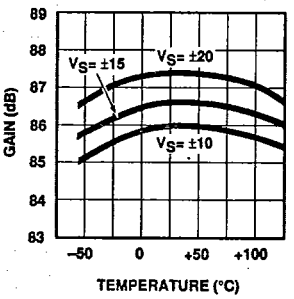
Normalized AC Parameters vs Supply Voltage at 25°C



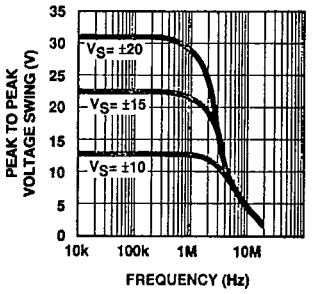
Open-Loop Frequency Response For Various Compensation



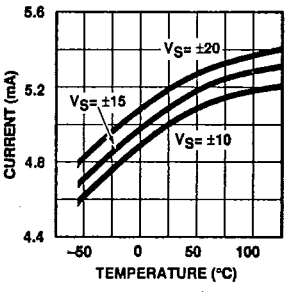
Open-Loop Voltage Gain vs Temperature



Output Voltage Swing vs Frequency at +25°C



Power Supply Current vs Temperature

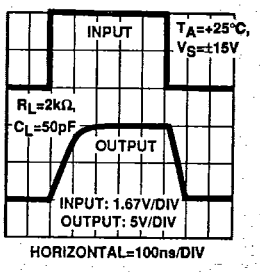


EHA2520/2522/2525

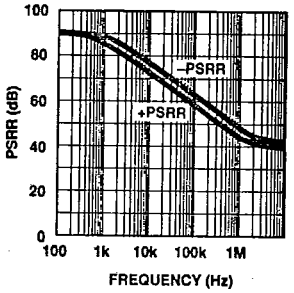
High Slew Rate Operational Amplifier

Typical Performance Curves - (continued)

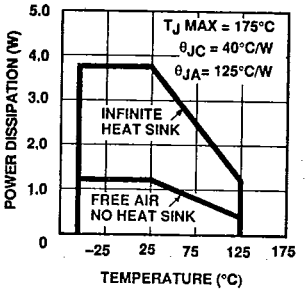
Pulse Response, $A_V = +3$



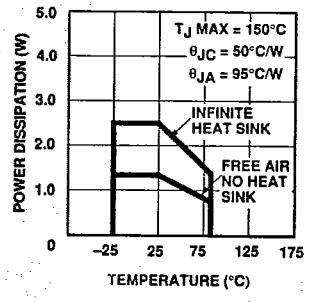
PSRR vs Frequency



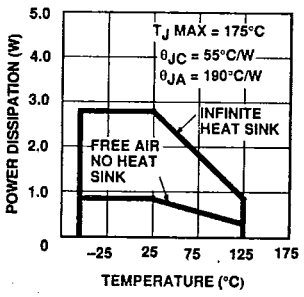
8-Lead CerDIP Maximum Power Dissipation vs Ambient Temperature



8-Lead Plastic DIP Maximum Power Dissipation vs Ambient Temperature



8-Lead TO-99 Metal Can Maximum Power Dissipation vs Ambient Temperature



20-Pad LCC Maximum Power Dissipation vs Ambient Temperature